

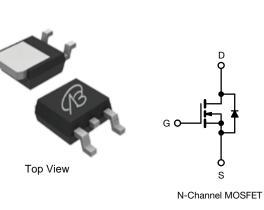
## N-Channel 650V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY				
$V_{DS}$ (V) at $T_J$ max.	650			
R <sub>DS(on)</sub> typ. (Ω) at 25 °C	$V_{GS} = 10 V$	0.340		

#### FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>g</sub>)
- Avalanche energy rated (UIS)





TO-252

#### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
  - Welding
  - Induction heating
  - Motor drives
  - Battery chargers
  - Renewable energy
  - Solar (PV inverters)

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_c = 25 \degree C$ , unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V <sub>DS</sub>	650	V	
Gate-source voltage			V <sub>GS</sub>	± 30	1 V	
Continuous drain surrant (T 150 °C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	۱ <sub>D</sub>	12		
Continuous drain current ( $T_J = 150 \ ^\circ C$ )		T <sub>C</sub> = 25 °C T <sub>C</sub> = 100 °C		7	А	
Pulsed drain current <sup>a</sup>			I <sub>DM</sub>	36		
Linear derating factor				1.7	W/°C	
Single pulse avalanche energy <sup>b</sup>			E <sub>AS</sub>	320	mJ	
Maximum power dissipation			P <sub>D</sub>	180	W	
Operating junction and storage temperature range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Drain-source voltage slope	T <sub>J</sub> = 125 °C		-l\ / / -l+	50		
Reverse diode dV/dt <sup>d</sup>			dV/dt	5.1	V/ns	
Soldering recommendations (peak temperature) <sup>c</sup>	For 10 s			260	°C	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature

- b.  $V_{DD}$  = 100 V, starting  $T_J$  = 25 °C, L = 30 mH,  $R_g$  = 25  $\Omega,\,I_{AS}$  = 6 A
- c. 1.6 mm from case
- d.  $I_{SD} \leq I_D$ , dl/dt = 100 A/µs, starting  $T_J$  = 25 °C

## **VBE165R12S**



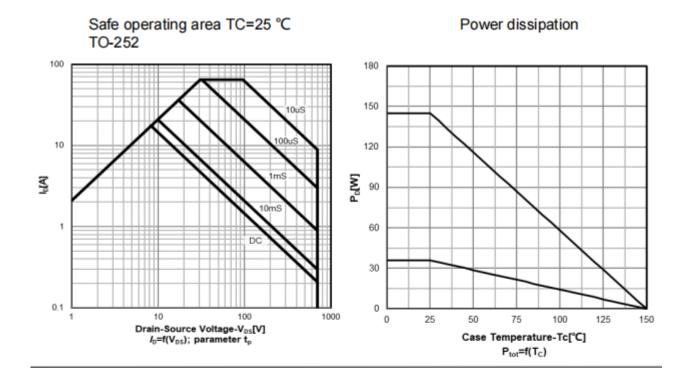
THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum junction-to-ambient	R <sub>thJA</sub>	- 62		00.00				
Maximum junction-to-case (drain)	R <sub>thJC</sub>	- 0.85				°C/W		
<b>SPECIFICATIONS</b> ( $T_J = 25 \text{ °C}$ , u	unless otherwi	se noted)						
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static								
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		650	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I <sub>D</sub> = 1 mA	-	1.08	-	V/°C
Gate-source threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> =	250 µA	2.0	-	4.0	V
	I <sub>GSS</sub>	$V_{GS} = \pm 20 V$		-	-	± 100	nA	
Gate-source leakage		$V_{GS} = \pm 30 \text{ V}$		-	-	± 1	μA	
		$V_{DS} = 650 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	1		
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 520 V	$V_{DS} = 520 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 \text{ °C}$		-	-	10	μA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I	<sub>D</sub> =4A	-	0.340	-	Ω
Forward transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	= 30 V, I <sub>D</sub> :	= 12 A	-	8.7	-	S
Dynamic	•					<u> </u>	•	1
Input capacitance	C <sub>iss</sub>	$\label{eq:VGS} \begin{array}{c} V_{GS}=0 \ V, \\ V_{DS}=100 \ V, \\ f=1 \ MHz \end{array}$		-	2500	-	pF	
Output capacitance	C <sub>oss</sub>			-	51	-		
Reverse transfer capacitance	C <sub>rss</sub>			-	12	-		
Effective output capacitance, energy related <sup>a</sup>	C <sub>o(er)</sub>	$V_{DS} = 0$ V to 480 V, $V_{GS} = 0$ V		-	48	-		
Effective output capacitance, time related <sup>b</sup>	C <sub>o(tr)</sub>			-	205	-		
Total gate charge	Qg				-	25	-	
Gate-source charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 12 \text{ A}, V_{DS} = 480 \text{ V}$		-	8	-	nC	
Gate-drain charge	Q <sub>gd</sub>			-	10	-		
Turn-on delay time	t <sub>d(on)</sub>				-	12	24	
Rise time	t <sub>r</sub>	Van -	V = 480 V L = 12 A		-	14	23	
Turn-off delay time	t <sub>d(off)</sub>	$V_{DD} = 480$ V, I <sub>D</sub> = 12 A, V <sub>GS</sub> = 10 V, R <sub>g</sub> = 9.1 Ω f = 1 MHz, open drain		-	61	110	ns	
Fall time	t <sub>f</sub>			-	16	-		
Gate input resistance	R <sub>g</sub>			0.3	0.7	1.4	Ω	
Drain-Source Body Diode Characteristi	cs							
Continuous source-drain diode current	١ <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	12		
Pulsed diode forward current	I <sub>SM</sub>			-	-	36	A	
Diode forward voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 12 A, V <sub>GS</sub> = 0 V		-	-	1.2	V	
Reverse recovery time	t <sub>rr</sub>				-	416	832	ns
Reverse recovery charge	Q <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = I <sub>S</sub> = 12 A, dl/dt = 100 A/ $\mu$ s, V <sub>R</sub> = 25 V		-	6.4	12.8	μC	
Reverse recovery current	I <sub>RRM</sub>			-	27	-	A	

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ 

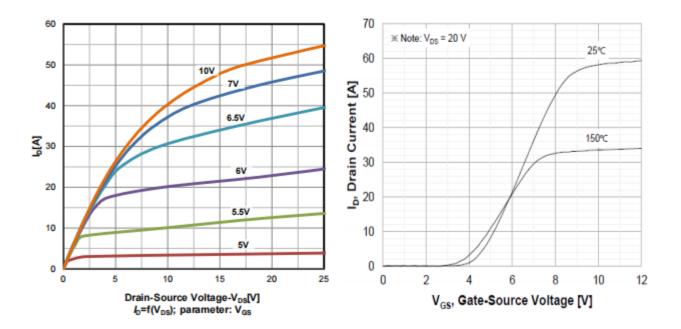


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



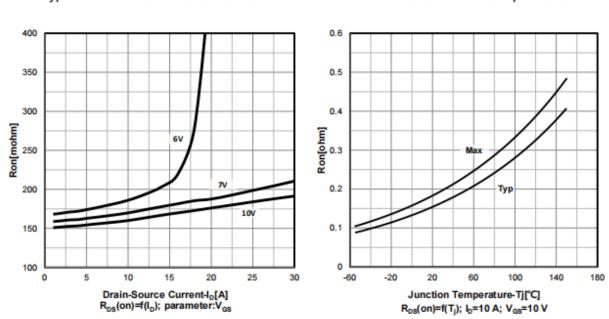
Typ. output characteristics  $T_i=25 \ ^{\circ}C$ 

Transfer characteristics



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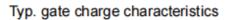


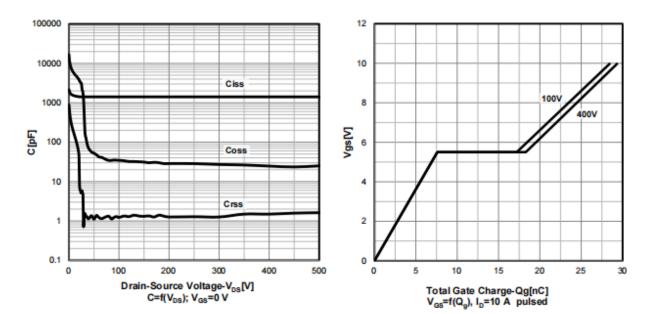


Typ. drain-source on-state resistance

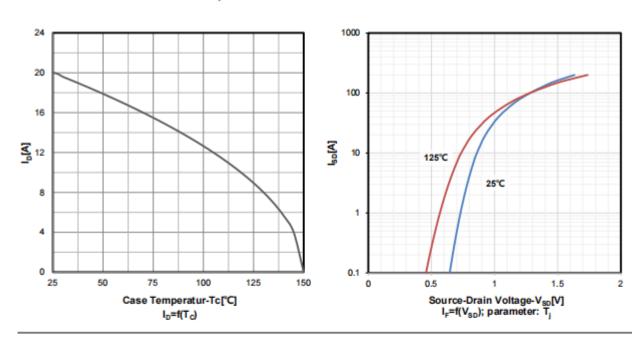
On-resistance vs temperature

Typ. capacitances







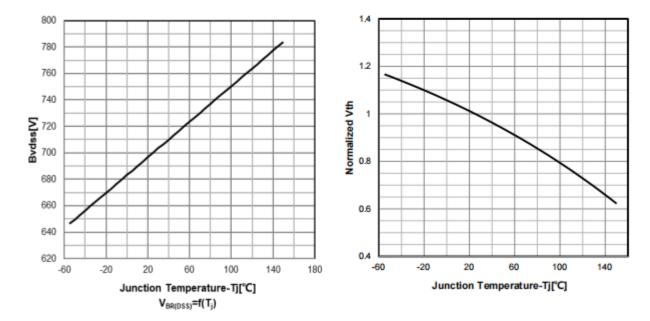


Drain current vs temperature

Forward characteristics of reverse diode

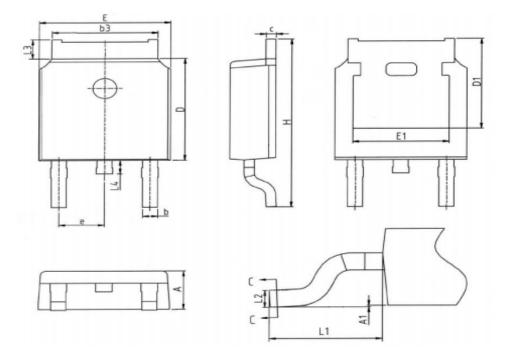
Drain-source breakdown voltage

Normalized VGS(th) characteristics





## Package Outline : TO 252



### COMMON DIMENSIONS

SYMBOL	UNIT(mm)				
SIMBOL	MIN	NOM	MAX		
A	2.20	2.30	2.40		
A1	0.00	-	0.127		
b	0.66	0.78	0.90		
b3	5.16	5.31	5.46		
с	0.43	0.53	0.63		
D	5.98	6.10	6.22		
D1	5.30REF				
E	6.40	6.75			
E1	4.63	-	-		
е	2.286BSC				
H	9.40	10.10	10.50		
L1	2.90REF				
L2	0.51BSC				
L3	0.88	1.08	1.28		
L4	0.50	0.80	1.00		



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